

IRFM9140 (JANTX2N7236)

PD-90495J

Power MOSFET

Thru-Hole (TO-254AA)

-100V, -18A, P-channel, HEXFET™ MOSFET Technology

Features

- Simple drive requirements
- Hermetically sealed
- Electrically isolated
- Dynamic dv/dt rating
- Light Weight
- ESD rating: Class 2 per MIL-STD-750, Method 1020

Potential Applications

- DC-DC converter
- Motor drives

Product Summary

- **BV_{DSS}** : -100V
- **I_D** : -18A
- **$R_{DS(on),max}$** : 0.20 Ω
- **Q_G, max** : 60nC
- **REF**: MIL-PRF-19500/595



Product Validation

Qualified to JANS screening flow according to MIL-PRF-19500 for space applications

Description

HEXFET MOSFET technology is the key to IR HiRel advanced line of power MOSFET transistors. The efficient geometry design achieves very low on-state resistance combined with high transconductance. HEXFET transistors also feature all of the well-established advantages of MOSFETs, such as voltage control, very fast switching and electrical parameter temperature stability. They are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers, high energy pulse circuits, and virtually any application where high reliability is required. The HEXFET transistor's totally isolated package eliminates the need for additional isolating material between the device and the heat sink. This improves thermal efficiency and reduces drain capacitance.

Ordering Information

Table 1 **Ordering options**

Part number	Package	Screening Level
IRFM9140	TO-254AA	COTS
JANS2N7236	TO-254AA	JANS
JANTX2N7236	TO-254AA	JANTX
JANTXV2N7236	TO-254AA	JANTXV

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Absolute Maximum Ratings

1 Absolute Maximum Ratings

Table 2 Absolute Maximum Ratings

Symbol	Parameter	Value	Unit
$I_{D1} @ V_{GS} = -10V, T_C = 25^{\circ}C$	Continuous Drain Current	-18	A
$I_{D2} @ V_{GS} = -10V, T_C = 100^{\circ}C$	Continuous Drain Current	-11	A
$I_{DM} @ T_C = 25^{\circ}C$	Pulsed Drain Current ¹	-72	A
$P_D @ T_C = 25^{\circ}C$	Maximum Power Dissipation	125	W
	Linear Derating Factor	1.0	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
E_{AS}	Single Pulse Avalanche Energy ²	500	mJ
I_{AR}	Avalanche Current ¹	-18	A
E_{AR}	Repetitive Avalanche Energy ¹	12.5	mJ
dv/dt	Peak Diode Reverse Recovery ³	-5.5	V/ns
T_J T_{STG}	Operating Junction and Storage Temperature Range	-55 to +150	°C
	Lead Temperature	300 (0.063 in. (1.6mm) from case for 10s)	
	Weight	9.3 (Typical)	g

¹ Repetitive Rating; Pulse width limited by maximum junction temperature.

² $V_{DD} = -25V$, starting $T_J = 25^{\circ}C$, $L = 3.1mH$, Peak $I_L = -18A$, $V_{GS} = -10V$

³ $I_{SD} \leq -18A$, $di/dt \leq -100A/\mu s$, $V_{DD} \leq -100V$, $T_J \leq 150^{\circ}C$

Device Characteristics

2 Device Characteristics

2.1 Electrical Characteristics

Table 3 Static and Dynamic Electrical Characteristics @ $T_j = 25^\circ\text{C}$ (Unless Otherwise Specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
BV_{DSS}	Drain-to-Source Breakdown Voltage	-100	—	—	V	$V_{GS} = 0V, I_D = -1.0mA$
$\Delta BV_{DSS}/\Delta T_j$	Breakdown Voltage Temp. Coefficient	—	-0.087	—	V/ $^\circ\text{C}$	Reference to 25°C , $I_D = -1.0mA$
$R_{DS(on)}$	Static Drain-to-Source On-State Resistance	—	—	0.20	Ω	$V_{GS} = -10V, I_{D2} = -11A^1$
		—	—	0.22		$V_{GS} = -10V, I_{D2} = -18A^1$
$V_{GS(th)}$	Gate Threshold Voltage	-2.0	—	-4.0	V	$V_{DS} = V_{GS}, I_D = -250\mu A$
G_{fs}	Forward Transconductance	6.2	—	—	S	$V_{DS} = -15V, I_{D2} = -11A^1$
I_{DSS}	Zero Gate Voltage Drain Current	—	—	-25	μA	$V_{DS} = -80V, V_{GS} = 0V$
		—	—	-250		$V_{DS} = -80V, V_{GS} = 0V, T_j = 125^\circ\text{C}$
I_{GSS}	Gate-to-Source Leakage Forward	—	—	-100	nA	$V_{GS} = -20V$
	Gate-to-Source Leakage Reverse	—	—	100		$V_{GS} = 20V$
Q_G	Total Gate Charge	—	—	60	nC	$I_{D1} = -18A$
Q_{GS}	Gate-to-Source Charge	—	—	13		$V_{DS} = -50V$
Q_{GD}	Gate-to-Drain ('Miller') Charge	—	—	35.2		$V_{GS} = -10V$
$t_{d(on)}$	Turn-On Delay Time	—	—	35	ns	$I_{D2} = -11A^{**}$ $V_{DD} = -50V$ $R_G = 9.1\Omega$ $V_{GS} = -10V$
t_r	Rise Time	—	—	85		
$t_{d(off)}$	Turn-Off Delay Time	—	—	85		
t_f	Fall Time	—	—	65		
$L_s + L_D$	Total Inductance	—	6.8	—	nH	Measured from Drain lead (6mm / 0.25 in from package) to Source lead (6mm/ 0.25 in from package) with Source wire internally bonded from Source pin to Drain pad
C_{iss}	Input Capacitance	—	1400	—	pF	$V_{GS} = 0V$ $V_{DS} = -25V$ $f = 1.0MHz$
C_{oss}	Output Capacitance	—	600	—		
C_{rss}	Reverse Transfer Capacitance	—	200	—		

****** Switching speed maximum limits are based on manufacturing test equipment and capability.

¹ Pulse width $\leq 300 \mu s$; Duty Cycle $\leq 2\%$

Device Characteristics

2.2 Source-Drain Diode Ratings and Characteristics

Table 4 Source-Drain Diode Characteristics

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
I_S	Continuous Source Current (Body Diode)	—	—	-18	A	
I_{SM}	Pulsed Source Current (Body Diode) ¹	—	—	-72	A	
V_{SD}	Diode Forward Voltage	—	—	-5.0	V	$T_J = 25^\circ\text{C}$, $I_S = -18\text{A}$, $V_{GS} = 0\text{V}$ ²
t_{rr}	Reverse Recovery Time	—	—	280	ns	$T_J = 25^\circ\text{C}$, $I_F = -18\text{A}$, $V_{DD} \leq -50\text{V}$
Q_{rr}	Reverse Recovery Charge	—	2.4	—	μC	$di/dt = -100\text{A}/\mu\text{s}$ ²
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$)				

2.3 Thermal Characteristics

Table 5 Thermal Resistance

Symbol	Parameter	Min.	Typ.	Max.	Unit
$R_{\theta JC}$	Junction-to-Case	—	—	1.0	$^\circ\text{C}/\text{W}$
$R_{\theta JCS}$	Case-to-Sink	—	0.21	—	
$R_{\theta JA}$	Junction-to-Ambient (Typical socket mount)	—	—	48	

¹ Repetitive Rating; Pulse width limited by maximum junction temperature.

² Pulse width $\leq 300\ \mu\text{s}$; Duty Cycle $\leq 2\%$

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Electrical Characteristics Curves

3 Electrical Characteristics Curves

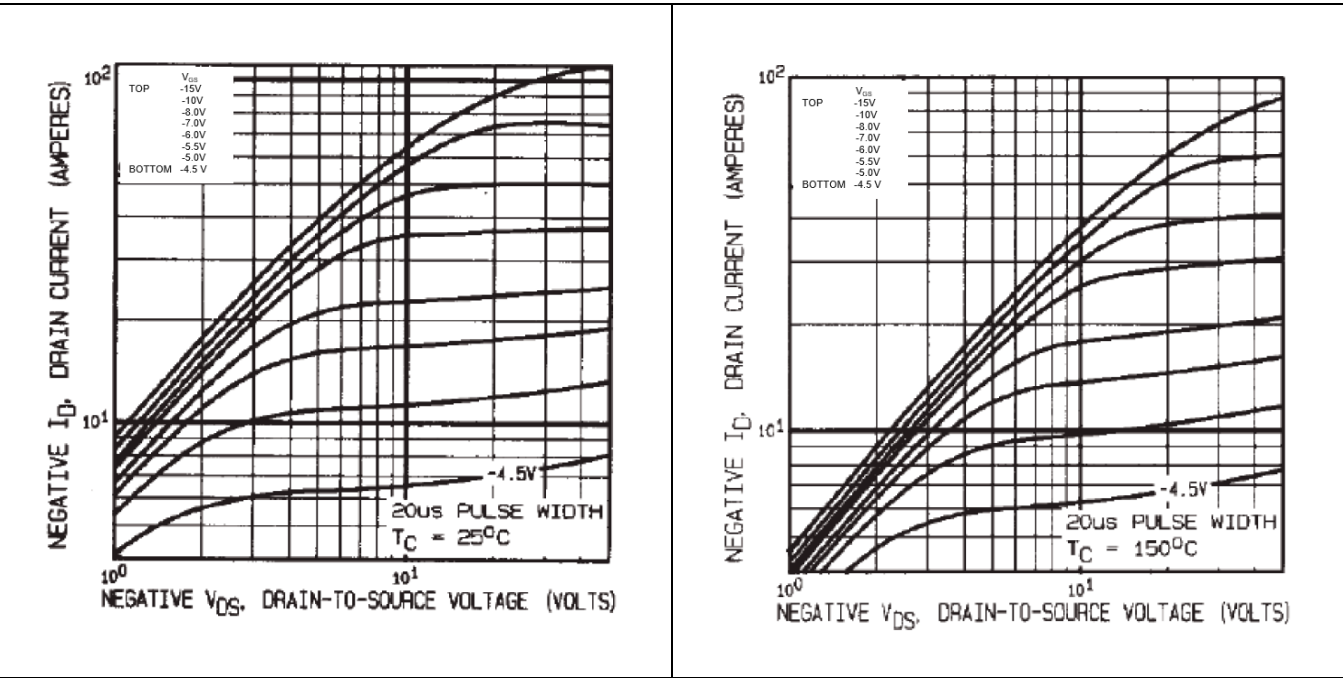


Figure 1 Typical Output CharacteristicsFigure 2 Typical Output Characteristics

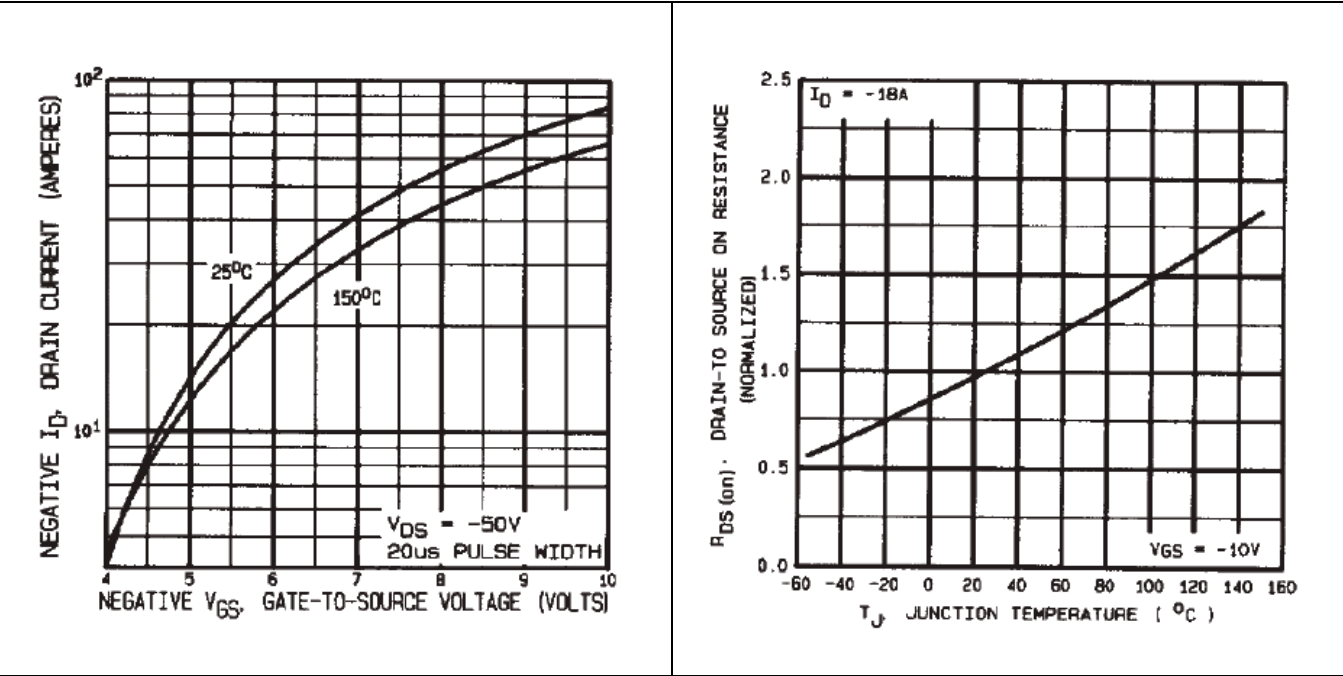


Figure 3 Typical Transfer CharacteristicsFigure 4 Normalized On-Resistance Vs. Temperature

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Electrical Characteristics Curves

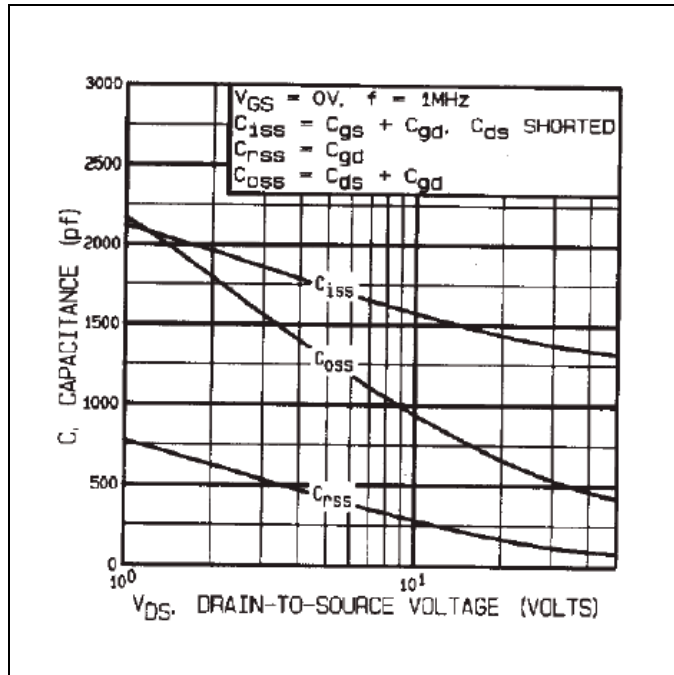


Figure 5 Typical Capacitance Vs. Drain-to-Source Voltage

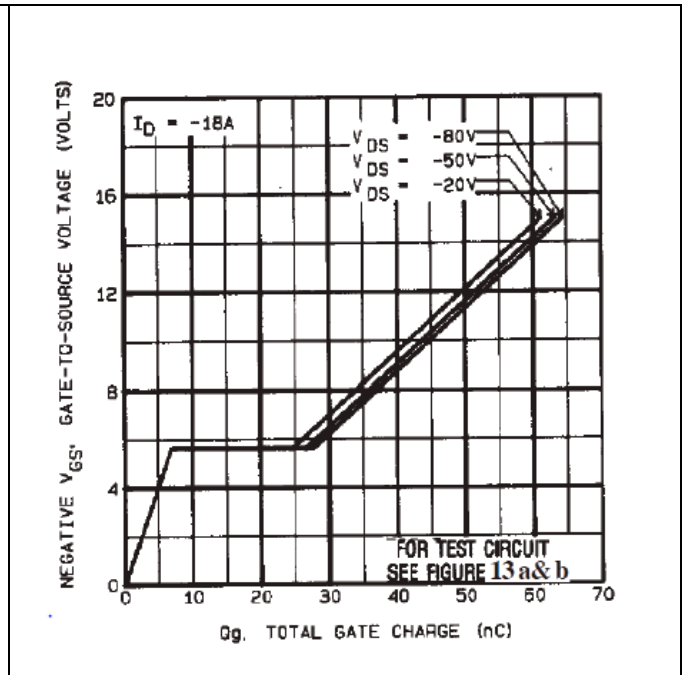


Figure 6 Typical Gate Charge Vs. Gate-to-Source Voltage

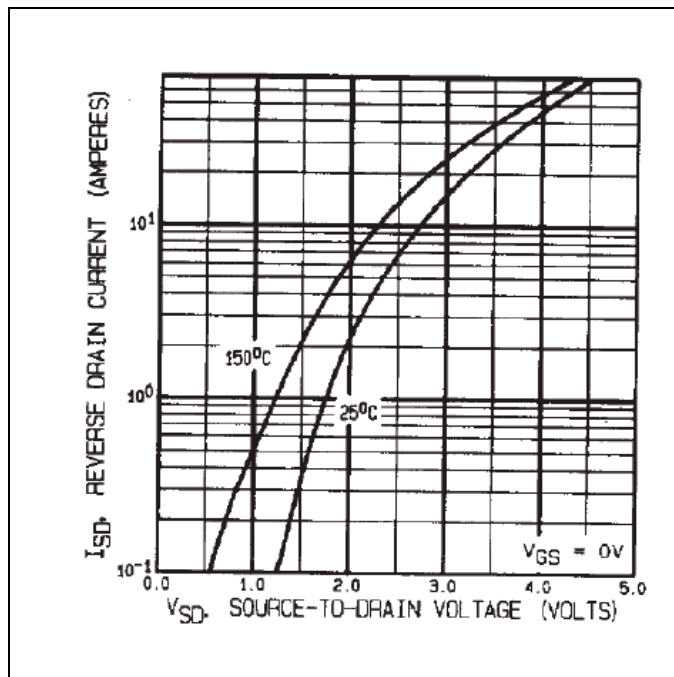


Figure 7 Typical Source-Drain Diode Forward Voltage

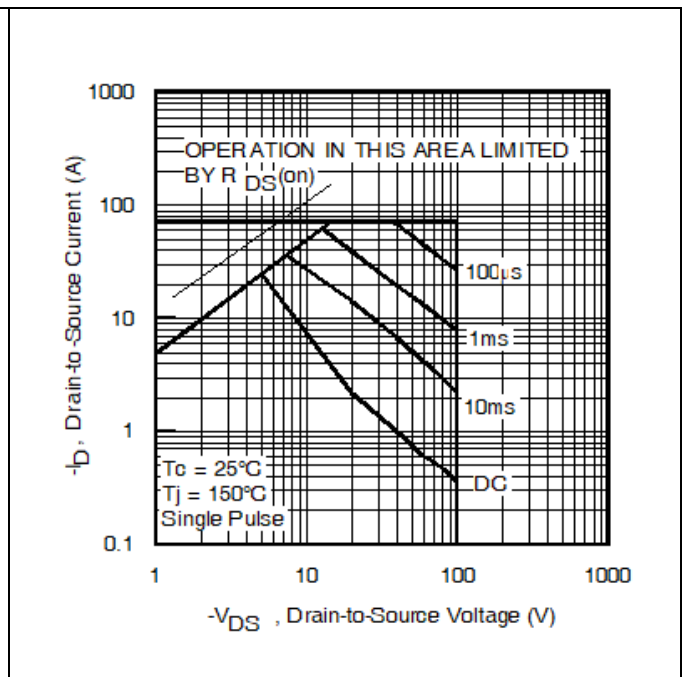


Figure 8 Maximum Safe Operating Area

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Electrical Characteristics Curves

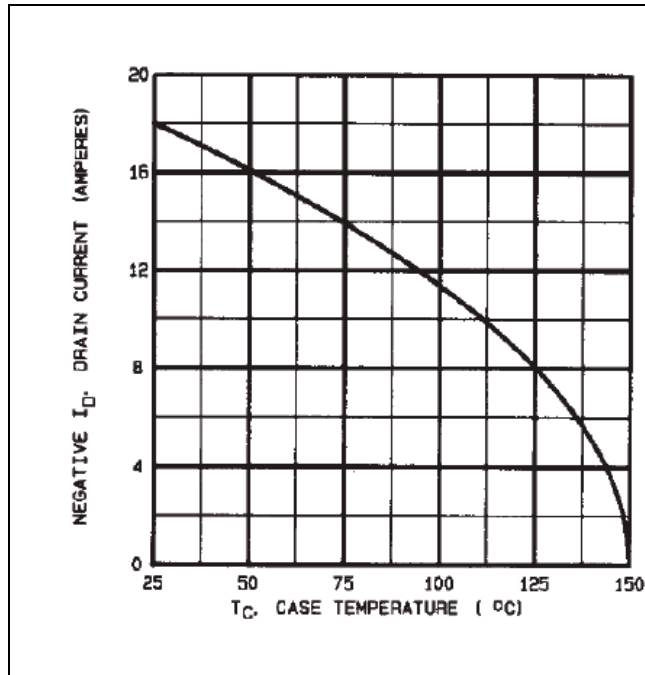


Figure 9 Maximum Drain Current Vs. Case Temperature

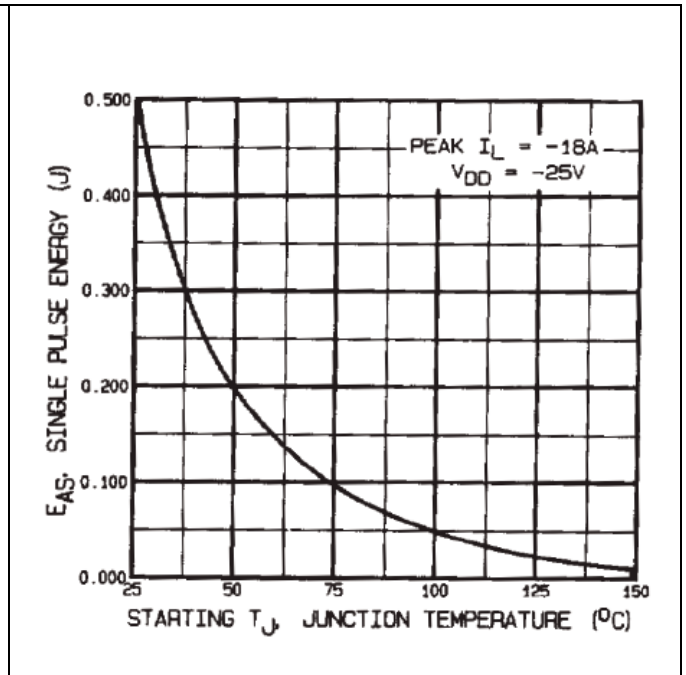


Figure 10 Maximum Avalanche Energy Vs. Junction Temperature

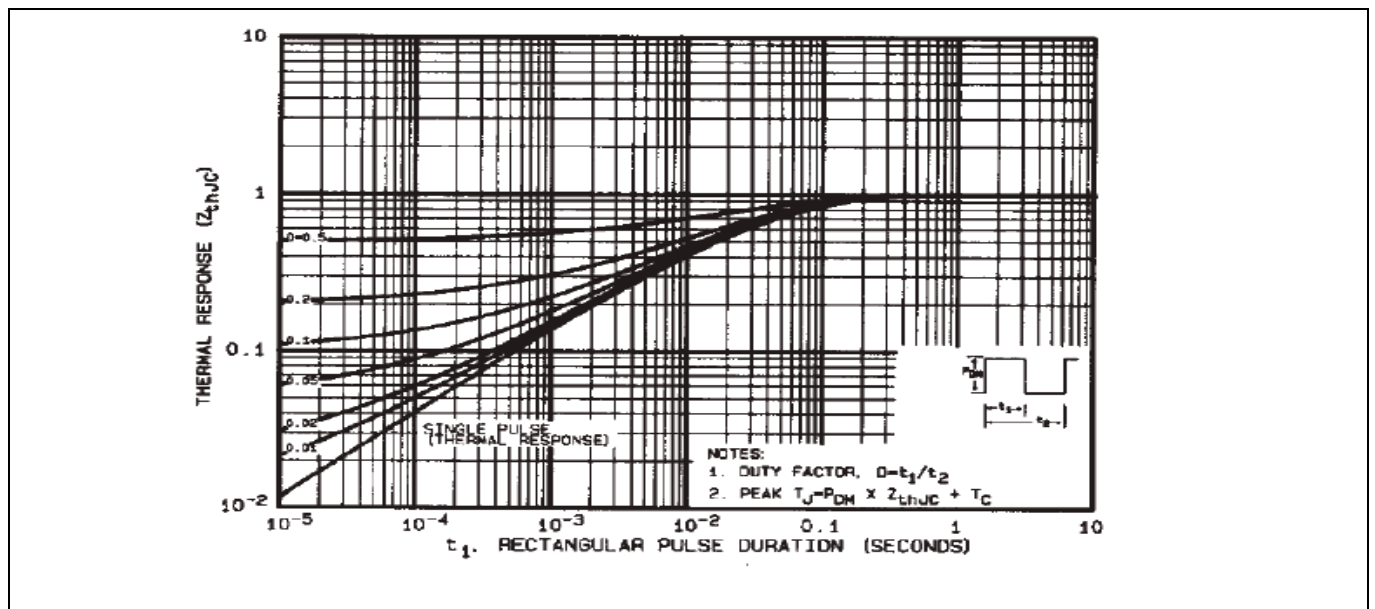


Figure 11 Maximum Effective Transient Thermal Impedance, Junction-to-Case

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Test Circuits

4 Test Circuits

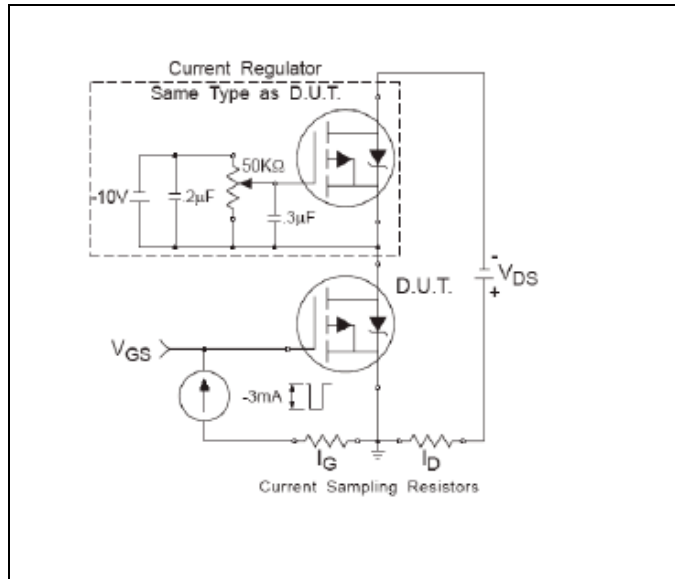


Figure 12 Gate Charge Test Circuit

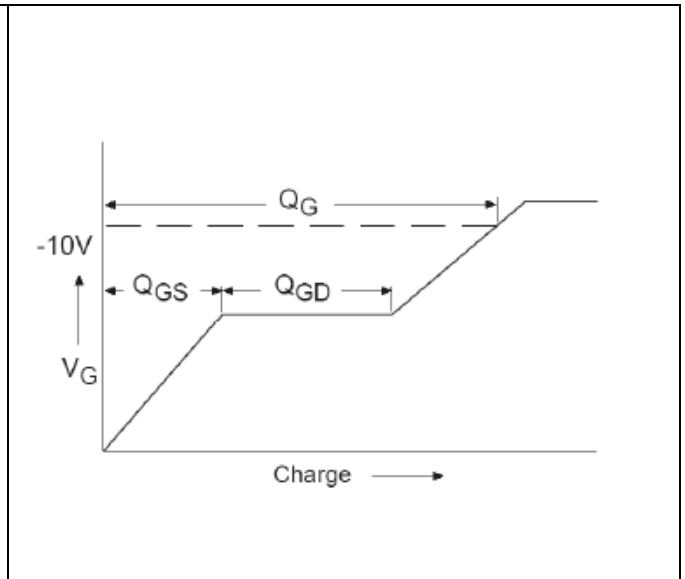


Figure 13 Gate Charge Waveform

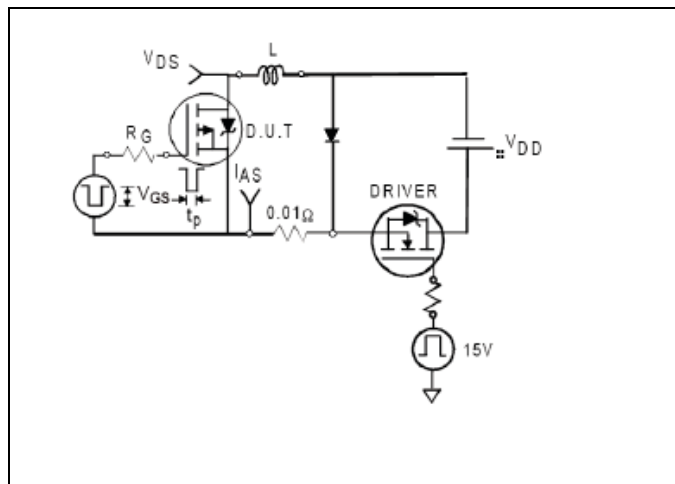


Figure 14 Unclamped Inductive Test Circuit

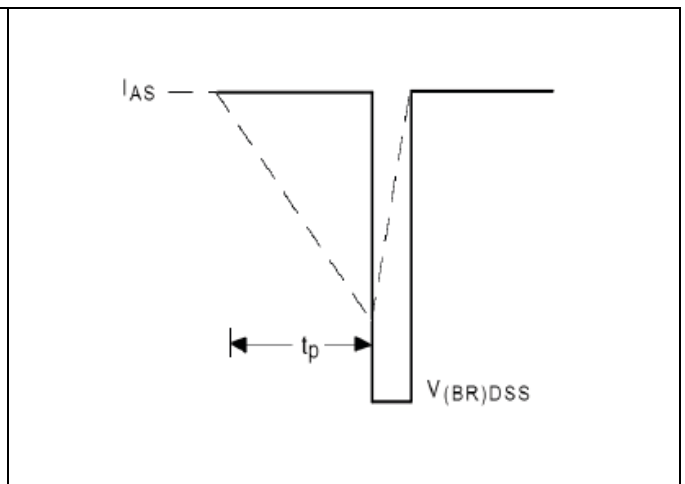


Figure 15 Unclamped Inductive Waveform

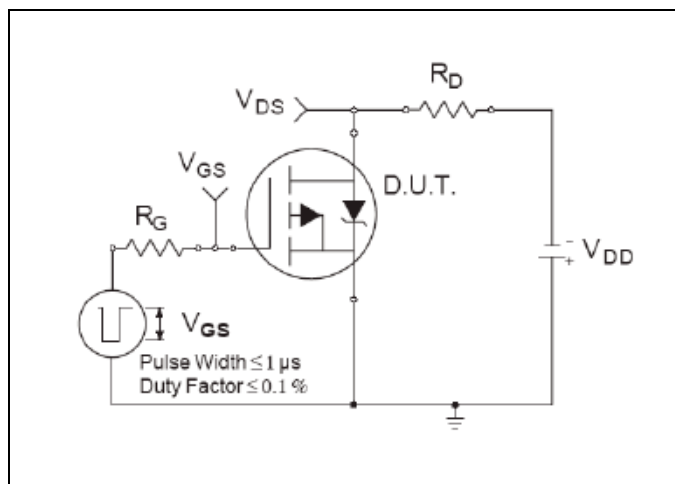


Figure 16 Switching Time Test Circuit

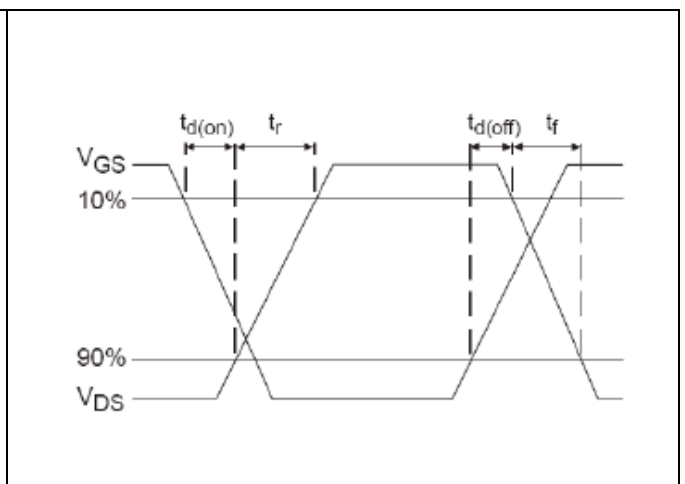


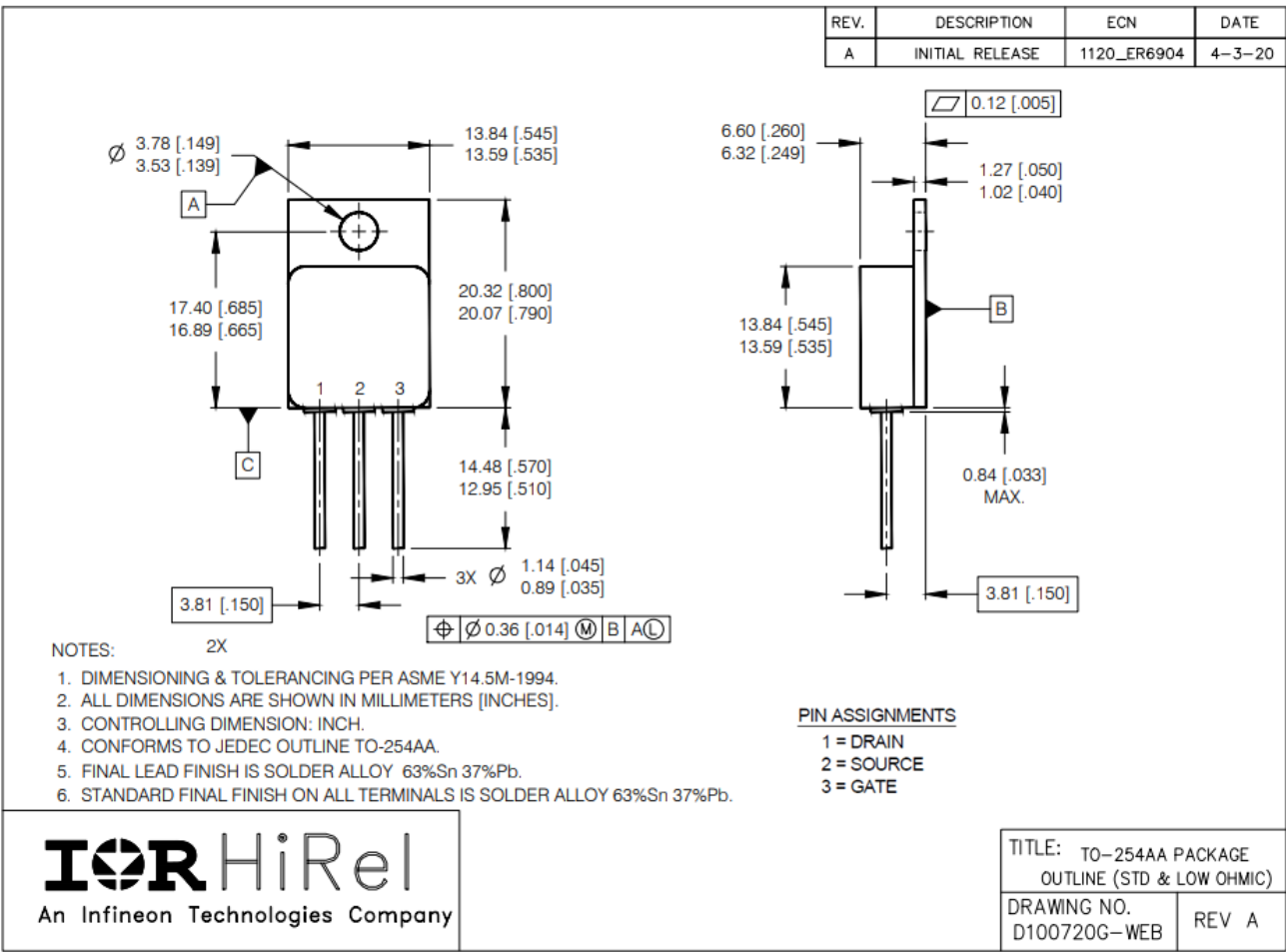
Figure 17 Switching Time Waveforms

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Package Outline

5 Package Outline

Note: For the most updated package outline, please see the website: [TO-254AA](http://www.infineon.com/toc-254aa)



BERYLLIA WARNING PER MIL-PRF-19500

Package containing beryllia shall not be ground, sandblasted, machined, or have other operations performed on them which will produce beryllia or beryllium dust. Furthermore, beryllium oxide packages shall not be placed in acids that will produce fumes containing beryllium.

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Revision history

Revision history

Document version	Date of release	Description of changes
Rev E	1/31/2002	Datasheet (PD-90495)
Rev F	11/18/2002	Added QPL Part number # JANS2N7236-page1
Rev G	09/22/2003	Updated based on ECN-11069
Rev H	06/22/2016	Updated based on ECN-1120_04401
Rev J	12/06/2024	Updated based on ECN-1120_10102

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Edition 2024-12-06

Published by

**International Rectifier HiRel Products,
Inc.**

**An Infineon Technologies company
El Segundo, California 90245 USA**

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